S/N: TBA4

06/14/2006 AP2DFREET NOT FIST 4-493 UN 2006

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Serial No.: TO BE ASSIGNED Confirmation No.: TO BE ASSIGNED

Applicant: Toru YAMADA et al. Art Unit: TO BE ASSIGNED

Filed: June 14, 2006 Examiner: TO BE ASSIGNED

Docket No: SUG-193-PCT Customer No: 28892

For: Vapor Phase Growth Apparatus and Method of Fabricating

Epitaxial Wafer

INFORMATION DISCLOSURE STATEMENT PURSUANT TO 37 C.F.R. §§ 1.56, 1.97, and 1.98

US Patent & Trademark Office Customer Service Window Randolph Building 401 Dulany Street Alexandria, VA 22314

Sir:

In compliance with the dictates of 37 C.F.R. §§ 1.56, 1.97, and 1.98, Applicant hereby submits an Information Disclosure. Statement.

Three of the attached seven documents are mentioned in the present specification and a brief description of their relevance can be found therein.

Applicant hereby reports the issuance of a Search Report in the corresponding Japanese application. A copy of that Search Report and two of the references cited therein (noted on attached PTO Form 1449) is attached hereto.

10/582860

06/14/2006

Docket No.: SUG-193-PCT

INFORMATION DISCLOSURE STATEMENT TRANSMITTAL - PAGE 2 of 2

It is respectfully requested that the Examiner consider each of these references and indicate such consideration by enclosing an appropriately initialled copy of the enclosed form PTO-1449 with the next communication from the Patent Office.

Respectfully submitted,

Req. No. 21,091

Signing for

Ronald R. Snider Attorney of Record Reg. No. 24,962

Date: June 14, 2006

S/N: TBA

Snider & Associates Ronald R. Snider P.O. Box 27613 Washington, D.C. 20038-7613 Tel.: (202) 347-2600 T) - 2

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INFORMATION DISCLOSURE STATEMENT - PTO FORM 1449

| FOREIGN PATENT DOCUMENTS . | | | | |
|----------------------------|---------------------------------------|---|--|-----|
| Examiner Initials* | Foreign Patent Document Number | Name of Patentee or Applicant of Cited Document | Date of Publication of Cited Document MM-DD-YYYY | T** |
| | JP 2002-231641 w/ English Abstract | Shinetsu Handotai KK Nagano Electronics Ind | 08-16-2002 | |
| | JP 2002-198316 w/ English Abstract | Shinetsu Handotai KK Nagano Electronics Ind | 07-12-2002 | |
| | JP 2001-44125 w/ English Abstract | Applied Materials Inc | 02-16-2001 | |
| | JP 2000-331939 w/ English Abstract | Applied Materials Inc | 11-30-2000 | |
| | JP 7-193015 | Applied Materials Inc | 07-28-1995 | х |
| | EP 0 637 058 A1 | Applied Materials Inc | 02-01-1995 | |
| | EP 0 637 058 B1 | Applied Materials Inc | 02-01-1995 | |

| | · |
|-----------------------|------------|
| Examiner | Date |
| Examiner Signature | Considered |

^{*}Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

^{**}Applicant is to place a check mark here if English language translation is attached